DEPARTMENT OF PHYSICS M. Tech in Advanced Materials Science and Technology

CURRICULUM

SEMESTER-I

Sl. No.	Subject Code	Subject L -		Credit
1	PH1001	Fundamentals of Materials Science	3 - 1 - 0	4
2	PH1002	Mechanical Behavior of Materials	3 - 1 - 0	4
3	PH1003	Optoelectronic Materials and Devices	3 - 1 - 0	4
4	****	Elective - I	3 - 1 - 0	4
5	****	Elective - II	3 - 1 - 0	4
6	PH1051	General Materials Science Lab	0 - 0 - 4	2
7	PH1052	Materials Synthesis & Characterization Lab	0 - 0 - 4	2
				24

SEMESTER-II

Sl. No.	Subject Code	Name of the Subject	L - T - P	Credit
1	PH2001	X-ray Diffraction & Structure of Materials	3 - 1 - 0	4
2	PH2002	Nano materials – Science & Technology	3 - 1 - 0	4
3	****	Elective - III	3 - 1 - 0	4
4	****	Elective - IV	3 - 1 - 0	4
5	****	Elective - V	3 - 1 - 0	4
6	PH2051	Computational Lab	0 - 0 - 4	2
7	PH2052	Seminar-I (Non-Project)/Sessional	0 - 0 - 2	1
8	PH2053	Project-I	0 - 0 - 2	1
				24

SEMESTER-III

Sl. No.	Subject Code	Name of the Subject	Credit
1	PH3051	Project-II	11
2	PH3052	Project Seminar-I	02
			13

SEMESTER-IV

Sl. No.	Subject Code	Name of the Subject	Credit
1	PH4051	Project-III	11
2	PH4052	Project Seminar-II & Viva Voce	03
			14
Total Programme Credit75			

Electives Subjects:

No.		
1	PH9011	Materials for Engineering Applications
2	PH9012	Numerical Analysis & Software Applications in Materials Science
3	PH9013	Semiconductor Materials and Device Technology
4	PH9014	Non-linear Optical Materials and Characterizations
5	PH9015	Techniques of Materials Characterization
6	PH9016	Thin-film Materials Technology
7	PH9017	Liquid Crystalline Materials
8	PH9018	Composite Materials
9	PH9019	Nuclear Reactor Materials
10	PH9020	Mechanical Behavior and Strong Materials
11	PH9021	Magnetic Properties and Magnetic Materials
12	PH9022	Fiber-optic Systems
13	PH9023	Electron Optics & Microscopy

SUMMARY OF COURSES

Subject	Name of the Subject	L - T - P	Credit	Name of the developer
code				
PH1001	Fundamentals of Materials	3 - 1 - 0	4	Prof. A. K. Meikap&
	Science			Dr S. Sahoo
PH1002	Mechanical Behavior of	3 - 1 - 0	4	Dr. S. Basu&
	Materials			Dr. A. Mondal
PH1003	Optoelectronic Materials	3 - 1 - 0	4	Prof. P. Kumbhakar &
	and			Dr. H. Chaudhuri
	Devices			
PH2001	X-ray Diffraction &	3 - 1 - 0	4	Dr. H. Chaudhuri
	Structure of			
	Materials			
PH2002	Nano materials – Science	3 - 1 - 0	4	Dr. A. Mondal
	&			
	Technology			

Electives Subjects:

Subject Code	Name of the Subject	L-T-P	Credit	Name of the developer
PH9011	Materials for Engineering Applications	3 - 1 - 0	4	Dr. A. K. Chakraborty
PH9012	Numerical Analysis & Software Applications in Materials Science	3 - 1 - 0	4	Dr. M. K. Mandal
PH9013	Semiconductor Materials and Device Technology	3 - 1 - 0	4	Dr. A. Mondal & Prof. A. K. Meikap
PH9014	Non-linear Optical Materials and Characterizations	3 - 1 - 0	4	Prof. P. Kumbhakar

PH9015	Techniques of Materials Characterization	3 - 1 - 0	4	Dr. A. K. Chakraborty
PH9016	Thin-film Materials Technology	3 - 1 - 0	4	Prof. A. K.
				Meikap
PH9017	Liquid Crystalline Materials	3 - 1 - 0	4	-
PH9018	Composite Materials	3 - 1 - 0	4	-
PH9019	Nuclear Reactor Materials	3 - 1 - 0	4	-
PH9020	Mechanical Behavior and Strong Materials	3 - 1 - 0	4	-
PH9021	Magnetic Properties and Magnetic Materials	3 - 1 - 0	4	-
PH9022	Fiber-optic Systems	3 - 1 - 0	4	Dr. M. K. Mandal
PH9023	Electron Optics & Microscopy	3 - 1 - 0	4	-

Sub Discipline: LABORATORY& SESSIONAL COURSES

SUBJECT CODE	SUBJECT L-T-P		CREDIT
PH1051	General Materials Science Lab	0 - 0 - 4	2
PH1052	Materials Synthesis & Characterization Lab	0 - 0 - 4	2
PH2051	Computational Lab	0 - 0 - 4	2
Sub Discipline: PROJ	ECT, SEMINAR etc.		
PH2052	Seminar-I (Non-Project)/Sessional	0 - 0 - 2	1
PH2053	Project-I		1
PH3051	Project-II		11
PH3052	2 Project Seminar-I		02
PH4051	Project-III		11
PH4052	Project Seminar-II & Viva Voce		03

Department of Physics							
Course	Title of the course	Program Core	Program Core Total Number of contact hours			Credit	
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l(T)	(P)	Hours	
PH1001	Fundamentals of	PCR	3	1	0	4	3
	Materials						
	Science						

Pre-requisites	Course Assessment methods (Continuous (CT) and end assessment			
NIL	(EA)) CT+EA			
Course Outcomes	• CO1: To demonstrate basic knowledge of various material properties.			
Outcomes	• CO2: To summarize various structural, electrical, thermal and magnetic			
	properties of materials.			
	 CO3: To exhibit knowledge of different techniques to characterize materials. 			
	materials.			
Topics	Topic 1: Crystal elasticity and lattice dynamics, Elastic stiffness and compliance			
Covered	coefficients, second and third order elastic constants, Cauchy relations, strain			
	energy function, Theory of lattice vibration, Born Karman condition, phonon			
	frequency distribution and dispersion relations, interaction of X-rays and neutrons			
	with phonons. [15]			
	Topic 2: Debye Waller factor and Mossbauer effect.[8]			
	Topic 3: Thermodynamic functions and relations for a crystal. Phase			
	transformations & multiphase equilibrium. [8]			
	Topic 4: Electronic energy band theory, classical free electron theory of solids,			
	Sommerfeld quantum free electron theory of a solid, Bloch wave-functions for a			
	periodic potential, Kronig-Penny model and energy bands. Fermi energy and Fermi			
	surfaces, effective mass of an electron, Brillouin zones & Reciprocal lattice. Many			
	electron theories. [13]			
	Topic 5: Electronic properties of Solids, Transport equation in presence of			
	magnetic field, cyclotron resonance, energy levels and density of states in presence			
	of magnetic fields. Landau diamagnetism and de-Haas van-Alphen effect. Hall			
	effect and magnetoresistance. Paramagnetism. [12]			
Text Books,	Text Books:			
and/or	1. Ashcroft & Mermin – Solid State Physics			
reference material	2. Animalu – Intermediate Quantum Theory of Crystalline Solids			
material	Reference Books:			
	1. Rogadski & Palmer - Solid State Physics			
	2. Pines – Elementary Excitations in Solids			
	3. Wallace – Thermodynamics of Crystals.			

		Department	of Physics				
Course	Title of the course	Program Core	Total Nu	mber of cor	ntact hours		Credit
Code		(PCR)/	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH1002	Mechanical Behavior of Materials	PCR	3	1	0	4	4
Pre-requisi		Course Assessmer (EA))	nt methods (Continuou	s (CT) and e	nd assessn	nent
NIL		CT+EA					
Course Outcomes	fundame • CO2: To mechani • CO3: T	To understand the ental physics persp o classify different ical properties of the o model the failu en their mechanica	ective. types of d ne materials re of cryst	lefects and s. alline ma	l infer their	influence	e on the
Topics Covered	engineering str encountered in region, yield po Behaviour, theo Topic 2: Elasti	duction to deformative resses and strains applications, Tension int, plastic deformative pretical estimates of city Theory: The Structure	, Differen ile Test - st ation, neck f strength o State of Str	t types o ress - stra ing and fra f materials ess and stu	f loading in response acture, Bond s. rain, stress a	and tem for metal ling and l and strair	perature l, elastic Material [10] n tensor,
	anisotropy, elas Topic 3: Yield Octahedral stre surface, Limita strain, effectiv	mation, principal tic behaviour of me ding and Plastic I ss, yield criteria a tion of engineering ve stress, effec od equation, stress	etals, ceran Deformatio and yield s g strain at 1 tive strai	nics and po n: Hydros urface, tex large defo n, flow	olymers. static and I sture and d rmation, tru rules, st	Deviatorio istortion le stress a rain ha	[5] c stress, of yield and true rdening,
	Topic 4: Mice classification of and glide, dislo and strain field interactions, par deformation be deformation of	croscopic view of defects, thermody ocation generation around dislocations, ethavior of single poly-crystals - Ha source limited pla asses.	vnamics of - Frank Re ns, force c twinning, c crystal, cr all-Petch ar	defects, g ad and gr on dislocat dislocatior ritical rese nd other h	eometry of ain boundat ion - self-s n movemen olved shear ardening m	dislocation ty source tress, dis t and stra stress (echanism	defects, ons, slip s, stress location ain rate, (CRSS), ns, grain
	fractures in n elasto-plastic fr	ure: fracture in ce netals, fracture m acture mechanics - re mechanics, effec	nechanics · JIC, Meas	- Linear surement a	fracture n nd ASTM s	nechanics standards,	5 -KIC, , Design

	and JIC, application of fracture mechanics in the design of metals, ceramics and polymers.
	[8]
	Topic 6: Deformation under cyclic load - Fatigue: S-N curves, Low and high cyclefatigue, Life cycle prediction, Fatigue in metals, ceramics and polymers.[5]
	Topic 7: Deformation at High temperature: Time dependent deformation - creep, different stages of creep, creep and stress rupture, creep mechanisms and creep mechanism maps, creep under multi-axial loading, microstructural aspects of creep and design of creep resistant alloys, high temperature deformation of ceramics and polymers.
	[8]
Text Books, and/or	Text Books: 1. Mechanical Metallurgy – George E. Dieter
reference material	2. Mechanical Behavior of materials – Thomas H. Courtney
	Reference Books:
	1. Strong solids – A. Kelly
	2. Materials Science and Engineering – William D. Callister, Jr.
	3. Mechanics of composite materials – Autar K. Kaw

		Department of					
Course	Title of the course	Program Core	Total Number of contact hours				Credit
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH1003	Optoelectronic	PCR	3	1	0	4	4
	Materials and						
	Devices						
Pre-requisi	tes	Course Assessmen (EA))	nt methods ((Continuou	s (CT) and er	nd assessm	nent
NIL		CT+EA					
Course Outcomes	and con • CO2: D radiatio • CO3: 0	To understand the v nmunication of ligh Describe the mechau n and technique of Calculate the lasin n of transverse mod	t in optical nism of ab generation g threshol	fiber. sorption, a of short p	amplificatio ulsed laser r	n, broade adiation.	ening of
	_	oefficient; Laser Ra	te Equatio				
	Topic 2: Lin Broadening and Topic 3: Res resonators, Mo selection techni Topic 4: Diffe laser, Nd:YAG Topic 6: "Q- mechanisms an Topic 7: Electr	Gain/Loss coefficient ne broadening M d Doppler Broadeni onators, Stability odes of Laser Radia iques, Gaussian bea rent types of lasers laser, Ti:Sa laser, C switching & mod d their comparison, co-optic effect, acou	Techanisms ng. of resonat ation, Long m propaga c, Principle CO ₂ laser e le-locking, methods c isto-optic e	, Spontan ors, g pa gitudinal a tion Gauss s of opera tc. different of mode-lo	neous trans arameters, w and transver sian beam fo tions of Ru methods cking. tro-optic ret	sition, C various ty se modes ocusing. by Laser, of Q-sw	[10] Collision [5] ypes of s, Mode [10] , He-Ne [6] vitching, [5]
	Topic 2: Lin Broadening and Topic 3: Res resonators, Mo selection techn Topic 4: Diffe laser, Nd:YAG Topic 6: "Q- mechanisms an Topic 7: Electr optic amplitude Topic 8: Optic	ne broadening M d Doppler Broadeni onators, Stability odes of Laser Radia iques, Gaussian bea rent types of lasers laser, Ti:Sa laser, C switching & mod d their comparison, ro-optic effect, acou	Techanisms ng. of resonat ation, Long of propaga of Principle CO ₂ laser e le-locking, methods of sto-optic e -modulatic step index	, Spontan ors, g pa gitudinal a tion Gauss s of opera tc. different of mode-lo offect, elect on of light. and grade	neous trans trameters, wind transver sian beam fo tions of Ru methods cking. tro-optic ret	sition, C various ty se modes ocusing. by Laser, of Q-sw ardation,	[10] Collision [5] ypes of s, Mode [10] , He-Ne [6] vitching, [5] electro- [10]
Text Books and/or reference material	Topic 2: Lin Broadening and Topic 3: Res resonators, Mo selection techni Topic 4: Diffe laser, Nd:YAG Topic 6: "Q- mechanisms an Topic 7: Electr optic amplitude Topic 8: Optic and single mod s, Text Books: 1. O. Svel 2. A. Gha Press (2 Reference Bool 1. W. Koe 2. A. Yari 3. J. Wilso	ne broadening M d Doppler Broadeni onators, Stability odes of Laser Radia iques, Gaussian bea rent types of lasers laser, Ti:Sa laser, C switching & mod d their comparison, co-optic effect, acou e modulation, phase al fibre waveguide: le fibre, attenuation to, Principles of Las tak and K. Thyagan 2003)	fechanisms ng. of resonat ation, Long im propaga c, Principle CO ₂ laser e le-locking, methods o isto-optic e -modulatic step index mechanism sers rajan, Opti Laser Engin nics wkes, Opto	, Spontan ors, g pa gitudinal a tion Gauss s of opera tc. different of mode-lo offect, elector on of light. and grade <u>ns in fibres</u> cal Electro	neous trans arameters, wand transver sian beam fo tions of Ru methods cking. tro-optic ret ed index fibr s etc.	sition, C various ty se modes ocusing. by Laser, of Q-sw ardation, re, multim	[10] Collision [5] ypes of 5, Mode [10] , He-Ne [6] vitching, [5] electro- [10] node [10]

		Department of	of Physics				
Course	Title of the course	Program Core	Total Nu	mber of coi	ntact hours		Credit
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH1051	General	PCR	0	0	4	4	2
	Materials						
	Science Lab						
Pre-requisites		Course Assessmen	nt methods	(Continuou	s (CT) and er	nd assessm	nent
		(EA))					
NIL		CT+EA					
Course	-	n experiments to und			-		
Outcomes	CO2: To exhibit	operating knowledge	e of devices	used for m	aterial charad	cterization	•
	CO3: To relate t	he concepts learned v	with the fun	ctioning of	everyday dev	vices.	
Topics	1. Band G	ap Measurement of	semicond	uctor			
Covered	2. Determ	2. Determination of Refractive index by Abbe refractrometer of different					
	liquid s			5			
	1	nation of Gaussian	beam dist	ribution of	He-Ne Lase	er beam	
		y the hall effect of a				er beuni	
		mine the Hysteresi	0			alc	
		U	-	0			
		rmine magneto resi		51		naterials	
		y the Electrolytic co		-	ystals		
	8. Determ	ination of efficiency	y of a solar	' cell			
Text Book							
and/or		course in practical pl	-	ttapadhyay	and Rakshit.		
reference material	2. Advanced pra	ctical Physics, K. G.	Mazumdar.				
	Reference Boo	ks:					
	1. A Te	tbook of Advanced I	Practical Ph	ysics, S. K.	Ghosh.		

			Department of					
Course	Title of the	course	Program Core	Total Nu	mber of cor	ntact hours		Credit
Code			(PCR) /	Lecture	Tutoria	Practical	Total	
			Electives (PEL)	(L)	l (T)	(P)	Hours	
PH1052	Materials		PCR	0	0	4	4	2
	Synthesis							
	Character	rization						
	Lab							
Pre-requisi	tes		Course Assessmen	nt methods	(Continuou	s (CT) and er	nd assessm	nent
			(EA))					
NIL			CT+EA					
Course		-	m experiments to	understand	fundament	tal concepts	of polyn	ners and
Outcomes	semico	nductors.						
			operating knowledge			5		
			e concepts learned v		ctioning of	everyday dev	vices.	
Topics	1.	Synthesi	s of a polymer con	nposite				
Covered	2.	2. Synthesis of a semiconductor nanoparticles by chemical method						
	3.	Preparati	ion of metal oxide	semicondu	ictor thin f	ilm		
	4.	Determi	nation of optical at	osorption c	haracterist	ics		
			l transport propert	-				
			ll transport propert	1 0	-	00100		
			nation of thermal s			omnosita		
			al characterization	-		-	a 110	
					5		que	
	9.	Spectral	characterization of	t SI & Ge J	onoto detec	ctors		
Text Book								
and/or			ourse in practical pl	-	ttapadhyay	and Rakshit.		
reference material	2. Adva	nced prac	tical Physics, K. G.	Mazumdar.				
	Refere	nce Book	s:					
		1. A Text	book of Advanced I	Practical Ph	ysics, S. K.	Ghosh.		

	1	Department of					
Course	Title of the course	Program Core		mber of co	1	1	Credit
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours	
PH2001	X-ray Diffraction & Structure of Materials	PCR	3	1	0	4	4
Pre-requis		Course Assessmer (EA))	nt methods ((Continuou	s (CT) and e	nd assessm	nent
NIL		CT+EA					
Course Outcomes	s characte nanoma • CO2: T about m • CO3: T	To demonstrate ki erizing materials (c terials). To list different tec aterial structures by o develop an under it to study novel m	rystalline, chniques f y x-ray diff rstanding o	amorphous or extract fraction. f the theor	s, quasi-cry ing quantita	stalline, p ative info	oolymer ormatior
Covered	Symmetry oper Microscopic sy Bravais Lattice polycrystalline Topic 2: X-ray atomic scattering scattering by a reciprocal latti Bragg's Law, identification by some important Topic 3: Scatte amorphous mate Topic 4: Sca diffraction, X- parameters. Di diffraction prof Topic 5: Effect treatment. Diffi important alloy. Topic 6: Char	state of matter. y diffraction: Kine ng factor, scatterin crystal, crystal stru ce and direct latt Laws of systemic y Hanawalt's meth applications. ering by conglome terials and liquids. I ttering by large ray microscopy, ffraction from po files. Estimation of ct of temperature fusion mechanism s. nge of perfect pol apportance of its stue	opic symi oup, Herma and long matical the g by a con acture factor absences od. Quanti erate of ato Radial Dist perfect cr Lang Ca lycrystallir defect para on diffrae n. Time-te	metry, Pa ann-Maugu -range o eory. Scat nglomerato or, Recipro rs. Ewald? from diffe tative estin oms arrang ribution an rystals, D mera, din ne materia ameters fr ction, Cha emperature hity by m	oint Group uin symbols order, Sing tering by an e of atoms ocal lattice, n 's sphere, f erent crysta mation of di ged irregular nalysis. Pynamical t rect observals. Fourier om Four lin ange of ph e transform echanical p is determina	o of syn of Space le cryst n electror in regula relations l Laue cor l systems ifferent pa rly, scatte theory of analysis ie shape a ase due ations o processes, tion.	mmetry e Group al and [12] n, atom or order between nditions c. Phase aphases [12] ering by [7] f X-ray defect of the analysis [8] to hea f som [6]

Text Books, and/or reference material	Text Books:1. S. K. Chatterjee, X-ray diffraction its theory and applications2. B. D. Cullity, X-ray diffraction
	Reference Books:1. M. M. Woolfson, An introduction to X-ray crystallography2. L. V. Azaroff, Elements of X-ray crystallography
	3. B. E. Warren, X-ray diffraction

		Department							
Course	Title of the course	Program Core		mber of co		-	Credit		
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours			
PH2002	Nano materials – Science & Technology	PCR	3	1	0	4	4		
Pre-requisi		Course Assessmer (EA))	nt methods	(Continuou	s (CT) and e	nd assessm	nent		
NIL		CT+EA							
Course Outcomes Topics	nanomat • CO2: To nanomat • CO3: T techniqu	o apply different i	microscopi riate nano life engine	c techniqu omaterials eering prob	ies and tool and their blems.	s to char characte	acterize		
Covered	and 3D nanostr of state function	ucture by solving of 1D, 2D and 3D hods: Discussion o	the Schroc D nanostruc	linger equ tures, proj	ation. Calcuperties nano	ılation of materials.	density		
			-		up meu	iou.	[2]		
		Mechanical technique: Ball milling method.[2]Bottom up method:							
	Application of 0 techniques for n CVD technique fabrication. Chemical metho	technique, vap Dblique Angle Dep anostructure fabric for nanostructure ods: sol-gel technic gett film growth te	position an cation. e fabrication que	d Glancin	g Angle De	position (GLAD		
	Top down meth		ennique.				[-]		
	Chemical and d ion beam metho Topic 2: Char Microscopy (FE ray diffraction (Topic 3: Meas properties, diele Topic 4: Inorga application. Nar Topic 5: Inorg	ry etching techniq d. acterization of na SEM), Transmissi GXRD). surement of mech ctric and electroni- nic semiconductor nomagnetic materia ganic nanomateria . Micromachining	anomateria ion Electro nanical pro c propertie r nanostruc als and dev als, organi	ls: Field-e n Microsc operties, tl s. ctures, fabr rices. c semicon	emission So opy (TEM), hermal prop rication, cha nductor nar	canning l grazing a perties, n practerizat	[9] Electron angle x- [5] nagnetic [7] tion and [6]		
Text Books	s, Text Books:								
Lent Dook	., I CAL DOUND.								

and/or reference	1. S. Kulkarni, Nanotechnology; Principles and Practices, Capital Publishing
material	2. Robert W. Kelsall , Ian W. Tlamley, Mark Geoghegan; Nanoscale Science and Technology
	Reference Books:1. S. C. Tjong, Nanocrystalline Materials, Elsevier
	2. Claire Dupas, Philippe Houdy, Marcel Lahmani, Nanoscience Nanotechnology and Nanophysics
	3. Hoshino & Mishima, Nanomaterials from Research to Applications, Elsevier

		Department	of Physics						
Course	Title of the course	Program Core	Total Nu	mber of co	ntact hours		Credit		
Code		(PCR) /	Lecture	Tutoria	Practical	Total			
		Electives (PEL)	(L)	l(T)	(P)	Hours			
PH2051	Computational	PCR	0	0	4	4	2		
	Lab								
Pre-requisi	tes	Course Assessment (EA))	nt methods	(Continuou	s (CT) and e	nd assessm	nent		
NIL		CT+EA							
Course	• CO1: T	o demonstrate capa	bility to ur	nderstand a	nd write co	mputer pi	ograms		
Outcomes		o exhibit knowledg							
		o develop an unde		0	1 1 0	0			
		nosen field through			-		1		
			-						
Topics Covered		ction to MATLAB			_				
Covereu		2. To Plot the Fermi- Dirac Probability distribution vs Energy Characteristics							
		of an intrinsic semiconductor at room temperature using MATLAB							
	3. To Plot	3. To Plot the Fermi- Dirac Probability distribution vs Energy Characteristics							
	of n-typ	e semiconductor at	room tem	perature us	sing MATL	AB			
	4. To Plot	the Fermi- Dirac l	Probability	distributio	on vs Energ	gy Charac	teristics		
	of p-typ	e semiconductor at	room tem	perature us	sing MATL	AB			
	5. To plot	t the carrier conc	entration	vs temper	ature chara	cteristics	for an		
	-	semiconductor		Ĩ					
		of state variables	Phase spa	ce & state	space) of a	given dv	namical		
	system	of state variables	(i nuse spu	ee et state	space) or a	Breen aj	inannicai		
	-	7. Estimate of Hurst exponent and Lyapunov exponent (nonlinear statistics) of							
		a dynamical system							
	5	cal solution of dif	foront int	aral and	differential	Aduation	e ucing		
		natica or MATLAB		egiai allu	unnerenniai	equation	is using		
	Iviainen		•						
Text Book	S Text Book: (1)	A First Course in C	omnutatio	nal Physic	η Τίμε Ο α	oVries			
and/or		un, ISBN: 978-0-70	-		.5, I UUI L. L	/C v 11C3,			
reference		un, 10011, 070-0-70	JJ/ /JI+-	т.					
material	Reference Bool	k: (1) Computationa	al Physics	, Landau R	ubin H, ISE	BN:			
	978352741315				-				

		Department of						
Course	Title of the course	Program Core	-	mber of co		L	Credit	
Code		(PCR) /	Lecture	Tutoria		Total		
PH9011	Materials for	Electives (PEL) PEL	(L) 3	l (T)	(P) 0	Hours 4	4	
PH9011	Engineering		5	I	0	4	4	
	Applications							
Pre-requisi	tes	Course Assessmen (EA))	nt methods ((Continuou	s (CT) and e	nd assessm	nent	
NIL		CT+EA						
Course Outcomes	engineer • CO2: T polymer	o outline differen ring materials. o explain differe , composite, glassy o identify appropria s.	ent modern 7, electrical	n technique and optic	ues for ch al materials	aracteriza	tion of	
Topics	Introduction to	• Materials: The n	naterial wo	orld, types	of material	s, Introdu	ction to	
Covered		s, polymers, comp						
	phase diagram Eutectoid, Perit Polymers : Type addition polym	terials: Metals and s of Fe-C system ectic diagrams, TT es of polymers, pol erization, degrada non polymers, their	m and co T diagram, lymerizatio tion and s	mmon no the Liver ns process stabilizatio	on-ferrous rule. ses, step pol on of polyr	alloys, E ymerizati ners, cor	Eutectic, [12] ons and	
	alloys, propertie	Ceramics & glasses: Types of ceramics, phase diagrams of common ceramicalloys, properties of common ceramics & glasses, their common applications and rocessing methods. [7]						
	composites, nar isostrain loadir	Types of composinocomposites, prop ng, Interfacial str osites, their process	perty avera ength, me	iging by F chanism	Rule of Mix of reinforc	ture, isos	stress &	
		Materials : Conductors, Conductivity and its temperature depen ctors, Superconductors.						
	transparency, o	r ials : Optical p pacity, etc., optica ystal displays, phot	al systems	and devi	luminescen ces, Laser i		-	
Text Book and/or reference		ford, M. K. Muralio	dhara, <i>Intro</i>	oduction to	o Materials	Science fo	or	

material	2. R. Balasubramaniam, Callister's Materials Science & Engineering
	3. W.F. Smith, J. Hashemi, R. Prakash, Materials Science & Engineering
	4. A. K. Bhargava, Engineering Materials
	Reference Books:
	1. Rolf E. Hummel, Understanding Materials Science : History, Properties,
	Applications
	2. John Martin, <i>Materials for Engineering</i>
	3. J. Simmons, K Potter, Optical Materials
	4. Fuxi Gan, Laser Materials

	1		ent of Physi				1			
Course Code	Title of the course	Program Core (PCR) /	Total Nur Lecture	nber of conta Tutorial	act hours Practical	Total	Credit			
		Electives (PEL)	(L)	(T)	(P)	Hours				
PH901 2	Numerical Analysis & Software Applications in Materials Science	PEL	3	1	0	4	4			
Pre-requis NIL	ites	Course Assessm CT+EA	ent methods	s (Continuou	s (CT) and en	d assessme	nt (EA))			
Course Outcomes	 problem CO2: T formula applica CO3: T data. 	o utilize knowle	proficiency problems edge of dif	of scientif related to ferent tools ysis of algo	ic software the propertie for analyzin prithms and	like MAT es of mate ng and int programm	LAB for erials and cerpreting ing, flow			
Covered	jumps, iteration oriented progra Topic 2: Appli computation, S Numerical inte order different Matrix eigenva Topic 3: Simu	cation of Program Solutions of eque egration and difficial equations, Sy	ns. Basics of mming to the ations by the ferentiation ferentiation for the stems of history of hist	of programm he followin iteration, F , Numerica inear equat	ning in C++, g problems: inite differen al solution o ions, Methoo	structure Errors in r nces, Inter f first an ls of least	&object- [15] numerical rpolation, d second squares, [26]			
Text Book and/or reference material	1. A Steven	1. A Stevens & Clayton Walnum, C++ Programming Bible								
		ks: aandraRao & C FORTRAN, Pasc			cal Methods	with pro	grams in			

		Department of	of Physics							
Course	Title of the course	Program Core	Total Nu	mber of coi	ntact hours		Credit			
Code		(PCR) /	Lecture	Tutoria	Practical	Total				
		Electives (PEL)	(L)	l (T)	(P)	Hours				
PH9013	Semiconductor	PEL	3	1	0	4	4			
	Materials and									
	Device									
	Technology									
Pre-requisit	es		Course Assessment methods (Continuous (CT) and end assessment							
		(EA))								
NIL		CT+EA								
Course	• CO1: T	o recall different	preparation	ı techniqu	es of single	e crystal	and IC			
Outcomes	fabricat	ion.								
	• CO2: T	o outline different	advanced [preparatio	n techniques	s such as	etching			
		ography for high sp	-	-	-		0			
		o apply the fundar		0 1		ctor mate	erials to			
		lopant profile create		-						
				r · ····						
Topics	Topic1: Prepar	ation of electronic	grade Si fr	om metall	urgical grad	e Si, Czo	chralski			
Covered	(CZ) method, F	(CZ) method, Float zone method, Silicon wafer fabrication. [10]								
	Topic 2: Oxid	Topic 2: Oxidation techniques, Growth kinetics, Oxide growth measurements								
	-	techniques, Defects in silicon, silicon dioxide, Interface defects, Point defect-based								
	-					ucres	[10]			
		Topic 3: Optical lithography, Deep UV lithography, Extreme UV lithography, Electron beam lithography, plasma and x-ray lithography techniques. [10]								
		0 1 0 1		0 1	-		[10]			
		etching of Si and	GaAs. Isot	ropic and	anisotropic	etching.				
	orientation dep	e					[7]			
	Dry etching, O	Classification of pl	lasma etch	ing techn	iques, react	ive ion	etching,			
	Inductive coup	e plasma reactive i	on etching	technique	etc.		[6]			
		sion and ion impla	-	-		ine mater	ials,			
		on techniques, Mod								
		rocess flow for IC t			L	Ŧ	[13]			
Text Books	_		0							
		1. S M Sze, Semiconductor Devices- Physics and Technology (2nd Ed.)								
and/or	1. 5 M 5Z6	, benneonauctor D		Joreo ana	O.))			
reference				0	01)			
		eetman & S Banerj		0	01)			
reference		eetman & S Banerj		0	01)			

		Department of	of Physics				
Course	Title of the course	Program Core		mber of co		1	Credit
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours	
PH9014	Non-linear	PEL	3	1	0	4	4
1110011	Optical			-			•
	Materials and						
	Characterization						
Pre-requis	ites	Course Assessmer (EA))	nt methods	(Continuou	s (CT) and e	nd assessm	ient
NIL		CT+EA					
 Course CO1: To illustrate propagation of electromagnetic waves in optical media CO2: To calculate the conversion efficiency of different nonli (SHG, SFG & DFM) processes. CO3: To identify mechanisms of damage in non-linear media minimize them. 						nonlinear	optical
Topics Covered	tensor of an an crystals. Topic 2: Intro interactions, nor Topic 3: Coup generation, and Techniques, nor Topic 4: Non properties, cha refractive index Topic 5: Laser damage thresho	romagnetic wave nisotropic medium oduction to Nonli- nlinear susceptibili oled-wave equatio parametric amplif nlinear optical inter inear optical mate- inear optical mate- induced damage ld on the laser pu ed damage in diffe	inear opti ty, classica n, sum-fre ication, M cactions wi erials, Orga ls. Optica (introducto lse duratio	ave propa cs, Descrip al anharmo equency n lanley-Row th focusse anic and i al Kerr o ory): Mech on, surface	gation, unia ptions of r mic oscillato nixing, diff ve relations d Gaussian norganic m effect, Inte nanism, dep e damage, b	axial and nonlinear or, Miller [*] erence-fre , phase-m beams. aterials at nsity de endencies ulk dama	biaxial [10] optical s rule. [9] equency atching [16] ad their pendent [10] s of the ge, and
Text Book and/or reference material	1. Y. R. Sh 2. R. W. B Reference Book	ke and J. E. Mic	tics Acade	mic Press	Inc.		

		Department of	of Physics				
Course	Title of the course	Program Core		mber of cor	ntact hours		Credit
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH9015	Techniques of Materials Characterization	PEL	3		0	4	4
Pre-requisi	tes	Course Assessmer (EA))	nt methods	(Continuou	s (CT) and e	nd assessm	nent
NIL		CT+EA					
Course Outcomes	different • CO2: T microsco materials • CO3: To	o explain differer materials. To demonstrate l opic techniques (T s. demonstrate know MA and DMA) for	knowledge EM, SEM wledge of (of diffe , SPM) for different th	erent optica characteriz ermal meth	al and ation of code (DTA	electron lifferent
Topics Covered	Principles and characterization Topic 2: Diffrace Topic 3: Micros analysis Topic 4: Micros Topic 5: Optica Topic 6: Electro Topic 7: Spi spectroscopies Topic 8: Therm Topic 9: Mecha	ials characterizati general method ction techniques - 2 scopy - optical, e scopy – scanning p l spectroscopies - 1 on spectroscopies	ds of co X-ray, elec lectron (T robe meth UV, visibl Auger an ectroscopio , TGA, DS easuremen	omposition etron and m EM & SE ods (STM, e, IR and F d photoelec es - NM GC, TMA a t of tensile	al, structu eutron diffra M) and elec AFM, EFM Caman spect ctron spectro IR, ESR nd DMA.	ral and action ctron mic 1, MFM e roscopies oscopies and Mc	defect [5] [7] roprobe [7] (12] (5] (7] (7] [7] [7]
Text Book and/or reference material	 Material Material Auger and 	s Characterization s Characterization- nd X-ray photoelec duction to Materia	-Yang Lan tron spect	g roscopy- D). Briggs and	d M. P. S	
		erization of Materia Principles of Elec				nann (Edi	tor)

		Department of									
Course	Title of the course	Program Core		mber of cor	1		Credit				
Code		(PCR) /	Lecture	Tutoria	Practical	Total					
DIIOOAC		Electives (PEL)	(L)	l(T)	(P)	Hours					
PH9016	Thin-film	PEL	3	1	0	4	4				
	Materials Technology										
Dro roquici	Technology	Course Assessmer	at mothodo	Continuou	(CT) and or	ad accord	l				
Pre-requisi	les	(EA))	it methous	Continuou		10 85565511	lent				
NIL		CT+EA									
Course	• CO1· T	o recall the techniqu	ues of fabr	ication of	different thi	n film ma	torials				
Outcomes	 CO2: 1 epitaxia CO3: 1 	Fo illustrate differ Il layer growth techr Fo compare the wo s and characterizatio	ent mecha nology. orking prin	anisms of nciples of	Vacuum PVD and	Technolo	ogy and				
Topics	Tonic 1. Gro	wth and structure	of films	General f	oaturos Nu	cleation	theorie				
Covered		on bombardment or									
				ture. Post-	- nucleation	giowii E	-				
	0	films and growth. Structural defects.[8] Topic 2: Preparation methods: Electrolytic deposition, cathodic and anodic films,									
			2	-							
	-	thermal evaporation, cathodic sputtering, chemical vapour deposition. Molecular									
		beam epitaxy and laser ablution methods. [8]									
	-	Topic 3: Vacuum science and techniques: Vacuum principles; Vacuum generation -									
	Rofary vane n	Rotary vane pump, Diffusion Pump, Turbomolecular Pump (TMP), Cryo-Pump; Vacuum measurement - Thermal conductivity vacuum gauges, Ionization vacuum									
		-	-				-				
		-	-				vacuun				
	Vacuum measi gauges.	urement - Thermal	conductivi	ty vacuum	n gauges, Io	nization	vacuun [8]				
	Vacuum measi gauges.	-	conductivi	ty vacuum	n gauges, Io	nization	vacuun [8]				
	Vacuum measi gauges. Topic 4: Thic	urement - Thermal	conductivi	ty vacuu n itoring: El	n gauges, Io	nization	vacuun [8]				
	Vacuum measi gauges. Topic 4: Thic interference, m	urement - Thermal kness measurement	conductivi and mon crystal me	ty vacuun itoring: El thods.	n gauges, Ic	onization echanical,	vacuun [8 optica				
	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal	urement - Thermal kness measurement iicrobalance, quartz	conductivi and mon crystal me f character	ty vacuum itoring: El thods. ization: Sr	n gauges, Ic ectrical, me nall angle 2	onization echanical, K-ray diff	vacuun [8 optica				
	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal	urement - Thermal kness measurement iicrobalance, quartz ytical techniques of	conductivi and mon crystal me f character	ty vacuum itoring: El thods. ization: Sr	n gauges, Ic ectrical, me nall angle 2	onization echanical, K-ray diff	vacuun [8 optica fraction				
	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal electron micro spectroscopy.	urement - Thermal kness measurement iicrobalance, quartz ytical techniques of	conductivi and mon crystal me f character ow energy	ty vacuum itoring: El thods. ization: Sr electron	n gauges, Ic ectrical, me nall angle 2 diffraction,	onization echanical, K-ray diff Auger e	vacuun [8 optica fraction emission [8]				
	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mec	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo	conductivi and mon crystal me f character ow energy of films:	ty vacuum itoring: El thods. ization: Sr electron Elastic ar	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b	onization echanical, K-ray diff Auger e oehavior.	vacuum [8 optica fraction mission [8] Optica				
	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mec properties. Re	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties	conductivi and mon crystal me f character ow energy of films: nsmittance	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra.	n gauges, Ic ectrical, me nall angle 2 diffraction, nd plastic b Absorbing	onization echanical, K-ray diff Auger e oehavior. 5 films.	vacuum [8 optica fraction emission [8] Optica Optica				
	Vacuum measi gauges. Topic 4: Thice interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fil	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and tra	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>L</i>	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropi	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr	onization echanical, K-ray diff Auger e pehavior. films. ropic film	vacuum [8 optica fraction emission [8] Optica s. [9				
	Vacuum measi gauges. Topic 4: Thick interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fill Topic 7: Elec	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and trai m material, Multilag	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cond	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropi ductivity i	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se	echanical, C-ray diff Auger e Dehavior. 5 films. Topic film	vacuum [8 optica fraction emission [8] Optica optica s. [9 ctor and				
	Vacuum measi gauges. Topic 4: Thick interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fill Topic 7: Elecc insulating film	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and trai m material, Multilay tric properties to fi	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>i</i> ilms: Cono ms. Supere	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropic luctivity i conducting	n gauges, Ic ectrical, me nall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuum [8 optica fraction emission [8] Optica optica s. [9 ctor and operties				
	Vacuum measi gauges. Topic 4: Thick interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fill Topic 7: Elecc insulating film	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and tran material, Multilay tric properties to fi s. Discontinuous fil films: Molecular	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>i</i> ilms: Cono ms. Supere	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropic luctivity i conducting	n gauges, Ic ectrical, me nall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuum [8 optica fraction emission [8] Optica optica s. [9 ctor and operties ropy in				
	Vacuum measi gauges. Topic 4: Thick interference, m Topic 5: Anal- electron micro spectroscopy. Topic 6: Mea properties. Re constants of fill Topic 7: Elect insulating film Magnetism of magnetic films	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and trai m material, Multilay tric properties to fi s. Discontinuous fil films: Molecular	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cono ms. Supera field theo	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropie luctivity i conducting ry. Spin v	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel wave theory	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuum [8 optica fraction emission [8] Optica s. [9 ctor and operties ropy in [7				
	Vacuum measi gauges. Topic 4: Thice interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fil Topic 7: Elect insulating film Magnetism of magnetic films Topic 8: Doma	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and tran material, Multilay tric properties to fi s. Discontinuous fil films: Molecular , ains in films, Applic	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cono ms. Supera field theo cations of r	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropid uctivity i conducting ry. Spin v nagnetic fi	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel wave theory	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuum [8 optica fraction emission [8] Optica Optica s. [9 ctor and operties ropy in [7 [4				
Text Books	Vacuum measi gauges. Topic 4: Thice interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fil Topic 7: Elecc insulating film Magnetism of magnetic films Topic 8: Doma Topic 9: Thin	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and trai m material, Multilay tric properties to fi s. Discontinuous fil films: Molecular	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cono ms. Supera field theo cations of r	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropid uctivity i conducting ry. Spin v nagnetic fi	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel wave theory	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuur [8 optica fraction missio [8] Optica Optica s. [9 ctor an operties ropy i [7 [4				
Text Books and/or	Vacuum measi gauges. Topic 4: Thic interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fil Topic 7: Elec insulating film Magnetism of magnetic films Topic 8: Doma Topic 9: Thin	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and tran material, Multilay tric properties to fi s. Discontinuous fil films: Molecular , ains in films, Applic	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cono ms. Supera field theo cations of r	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropid ductivity i conducting ry. Spin v nagnetic fi application	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel wave theory llms. ns.	echanical, echanical, K-ray diff Auger e ehavior. films. opic film miconduc ectric pro	vacuur [8 optica fraction emissio [8] Optica s. [9 ctor an operties ropy i [7				
	Vacuum measi gauges. Topic 4: Thice interference, m Topic 5: Anal electron micro spectroscopy. Topic 6: Mea properties. Re constants of fill Topic 7: Elecc insulating film Magnetism of magnetic films Topic 8: Doma Topic 9: Thin s, Text Books: 1. K.L. Cho	urement - Thermal kness measurement icrobalance, quartz ytical techniques of scopy, high and lo chanical properties eflectance and trais m material, Multilay tric properties to fi s. Discontinuous fil films: Molecular , ains in films, Applic film devices: Fabric	conductivi and mon crystal me f character ow energy of films: nsmittance yer films, <i>A</i> ilms: Cond ms. Supere field theo cations of r cation and a nomena; N	ty vacuum itoring: El thods. ization: Sr electron Elastic ar spectra. Anisotropic ductivity i conducting ry. Spin v nagnetic fi application IcGraw-Hi	n gauges, Ic ectrical, me mall angle 2 diffraction, nd plastic b Absorbing c and gyrotr n metal, se g films. Diel wave theory films. ns.	onization echanical, X-ray diff Auger e behavior. films. ropic film miconduc ectric pro y. Anisot	vacuur [8 optica fraction emissio [8] Optica optica s. [9 ctor an operties ropy i [7 [4 [4				

1. Thin Films; Heavens; Dover Publications Inc.; 1991
 Thin-Film Deposition: Principles and Practice; Smith; McGraw-Hill; 1995 Handbook of Thin Film Technology; Maissel & Glang; McGraw-Hill; 1970

		Department of	of Physics				
Course	Title of the course	Program Core	Total Nu	mber of cor	ntact hours		Credit
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH9017	Liquid	PEL	3	1	0	4	4
	Crystalline						
	Materials						
Pre-requisi	tes	Course Assessmen (EA))	nt methods ((Continuou:	s (CT) and er	nd assessm	ient
NIL		CT+EA					
Course Outcomes	 Outcomes CO2: To name the basic phases and phase transitions of anisotropic crystalline materials. CO3: To explain the various applications of liquid crystalline materia 					c liquid	
Topics Covered	transitions; anis crystals. Topic 2: Fern nanoscience. Topic 3: Photon	otropic materials; ro and antiferroe nics and microwave uid crystal appli manufacturing	symmetry lectric liq e electronic cations L	aspects; op juid cryst cs, overvie CDs, pre	ptics; electro als; examp w of the res	o optics of the optics of the optics of the optical sector of the	of liquid [15] LCs in [13] nt. [13]
Text Book							
and/or reference material		P.G. de Gennes: T lings, Liquid Crysta	1 0	-	5		
		s: r G. Chigrinov, V nt of Liquid Crysta					

		Department of	of Physics				
Course	Title of the course	Program Core	-	mber of cor			Credit
Code		(PCR) /	Lecture	Tutoria	Practical	Total	
		Electives (PEL)	(L)	l (T)	(P)	Hours	
PH9018	Composite	PEL	3	1	0	4	4
D	Materials		1 1 .			1	
Pre-requisi	tes	Course Assessmen (EA))	nt methods (Continuou	s (CT) and er	nd assessm	ient
NIL		CT+EA					
Course Outcomes	 CO3: To outline the fabrication and processing of metal matrix polymer Matrix (PM) and ceramic matrix (CM) composites and characterization. 						(MM),
Topics Covered	 Topic 1: Introduction to composite materials along with its basic requirement classification; Various models analyzing the design and performance of commaterials; Understanding the composite modulus, strength and fracture being for structural applications. Topic 2: Composites including nano-composites for electrical, superconduct device applications; Fabrication and processing of metal matrix (MM). Topic 3: Polymer Matrix (PM) and ceramic matrix (CM) composites are characterization; Fabrication of nano-composites. Topic 4: Secondary processing and joining of various composite material structural applications and their fracture behavior and safety. 						mposite haviour [18] ting and [12] nd their [13]
Text Book and/or reference	1. K.K. (Chawala, Composite Ajayan, L. S. Schadler,		2nd ed. Sp	ringer-Verla	ng, New Y	York

		Department of					
Course	Title of the course	Program Core		mber of cor		T-4-1	Credit
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours	
PH9019	Nuclear Reactor Materials	PEL	3	1	0	4	4
Pre-requisi	tes	Course Assessmer (EA))	nt methods ((Continuou	s (CT) and e	nd assessm	ient
NIL		CT+EA					
Course Outcomes	CO2: T material	 CO1: To show fundamental understanding of nuclear systems. CO2: To outline different modes of radiation damage in crystallimaterials. CO3: To identify basic reactor materials, LWR core materials, and radiation growth. Topic 1: Overview of Nuclear Systems Various types (LWR, PHWR, GCR, FB)					
Topics Covered	 Fusion). Topic 2: Mater Diffusion in So due to PKA. Topic 3: Prope Creep. SCC (& Topic 4: Dislo Dislocations. Hardening: Disl Topic 5: Prec Microstructural Embrittlement a Topic 6: React Void Swelling (ials - Selection Na olids, Radiation Da erties of Materials corrosion). cation Theory. Ty Dislocation Inter- location. Cipitation, Grain-b Changes. Friction and Fracture. or Materials, LWF Stainless Steels). ation Induced vs	ture of Ma amage, Bir a. Mechani pes. Stress actions. I ooundary, a and Sou & Core Ma	aterials Cry nary Elasti ical Prope Fields ar Dislocation Solution, arce Harde terials Rae	vstal Structu c Collisions rties. Fractu nd Strain En n Sources Strain. Ra ening. Fract diation Grow	ure Imper s, Displac ure, Fatig nergy. Fo and F adiation ture and wth - Zir	[7] fections cements [9] gue and [8] orces on Pile-ups. [8] Effects. DBTT. [10] caloys , [7]
Text Book and/or reference material	s, Text Books: 1. S. Glass Vol. 1 & 2. J. Kenn Nuclear Reference Book 1. R.L. Mu the Conc 2. A.E. Wa	stone, A. Sesonsko 2, eth Shultis, Richa Science and Engin	ard E. Fa eering, 200 Heinemanr I Applicatio s, Fast Bre	w, Marcel)2. 1, Nuclear ons of Nuc eder React	Dekker, D Energy: An clear Procest tors, Pergan	Fundamer Introduct ses, 5/e, 2	neering, ntals of tion to 2000.

		Department o								
Course	Title of the course	Program Core		mber of con		T ()	Credit			
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours				
PH9020	Mechanical Behavior and Strong Materials	PEL	3	1	0	4	4			
Pre-requisi		Course Assessmer (EA))	nt methods (Continuou	s (CT) and er	nd assessm	ient			
NIL		CT+EA								
Course Outcomes	 CO2: T CO3: T 	o show a fundamen o identify various c o relate the macros opic defects presen	rystal struc copic mec	ture impe	fections.		with the			
Topics Covered	for stress in 2- Strain; strain materials, aniso for stress and	of stress and strain d Transformation deviator; Mohr's otropic material St strain, criteria fo ngth of materials.	of stress in circle for ress-strain	n 3-d; Mc strain E curves; p	ohr's circle Clasticity: c lasticity; en	for stress origins, in npirical r	s in 3-d sotropic elations			
	theory, Implica crystalline soli	Topic 2: Defects in crystalline solids, Slip by dislocation motion and dislocation theory, Implications of dislocation motion and dislocation multiplication, Slip in crystalline solids, Deformation twinning and kink bands, Elastic properties of dislocations, Dislocations in common crystal structures. [13]								
		Topic 3: Dislocation mobility, stress-strain behavior, and yield point phenomena, Obstacle-based strengthening; introduction to strengthening mechanisms.[8]								
	strain aging, Pr	Topic 4: Work/strain hardening, Grain size hardening, Solid solution hardening and strain aging, Precipitation hardening, Strain gradient hardening and deformation of multiphase aggregates. [8]								
	Fracture, Creep and strengtheni	Topic 5: Comments on development of crystalline solids for maximum strength, Fracture, Creep & superplasticity, Fatigue of materials, Martensitic transformations and strengthening, Mechanical behavior of ordered alloys, Mechanical behavior of composite materials, Mechanical behavior of polymeric materials Hardness testing. [12]								
Text Book	s, Text Books:									
and/or reference material	1. G.E. Di	eter, "Mechanical N ical Behavior of ma	00							
	1. R.W. H	Reference Books: 1. R.W. Hertzberg, "Deformation and Fracture Mechanics of Engineering Materials", John Wiley and Sons, 1976.								

		Department of	of Physics							
Course	Title of the course	Program Core	Total Nu	mber of co	ntact hours		Credit			
Code		(PCR) /	Lecture	Tutoria	Practical	Total				
		Electives (PEL)	(L)	l (T)	(P)	Hours				
PH9021	Magnetic	PEL	3	1	0	4	4			
	Properties and									
	Magnetic									
	Materials									
Pre-requis		Course Assessme	nt methods	(Continuou	s (CT) and e	nd assessm	nent			
1		(EA))								
NIL		CT+EA								
Course	• CO1: T	o be able to classify	v different	types of m	agnetic mat	erials				
Outcomes		o be able to apply			0		rigin of			
	magnet		quantani	incentites						
		o be able to explai	n the mole	cular orig	ins of highe	r order n	nagnetic			
		es such as magnetic					lagilette			
	properti	les such as magnetio	c anisotrop	y and don		011.				
Topics	Topic 1: Classi	fication, Dia, Para,	Ferro, Ant	iferro and	Ferrimagne	tism, Lan	gevin			
Covered	-	and Weiss theories. [15]								
	Topic 2: Ouan	Topic 2: Quantum theory of diamagnetism, Paramagnetism, Hund rule, Crystal								
		field splitting, Exchange interaction, Magnetic anisotropy, Magnetic domains,								
	Magnetic order	~	,		P <i>J</i> , 11081100		[13]			
	0	ular theory, Hyster	esis Hard	and soft m	agnetic mat	erials Fe				
	structure, Magi		coio, 11010		ugnetic mut	critaio, r c	.[13]			
		conductivity, Meiss	ner effect	Type I and	d Type II su	nercondu				
		-				-				
	1 1	Heat capacity, London equation and penetration of magnetic field, Cooper pairs and								
	BCS ground sta	ate					[15]			
Torrt D. 1	a Transf D l									
Text Book					0.14	1				
and/or reference		ert, Electrical And	Magnetic	Properties	Ut Materia	is, Artech	n House			
material		ers, 1988								
matchial	2. B. D. C	ullity, C. D. Grahar	n, Introduc	ction to Ma	agnetic Mate	erials, Wi	ley			
	Reference Boo	76.								
			Ingnoticm	And Mag	notia Matari	iala Char	man P-			
		Introduction To M	agnetisin	Allu Magi	neuc water	iais, Châț				
	Hall, 19	190								

		Department of								
Course	Title of the course	Program Core		mber of cor		m · 1	Credit			
Code		(PCR) / Electives (PEL)	Lecture (L)	Tutoria l (T)	Practical (P)	Total Hours				
PH9022	Fiber-optic	PEL PEL	3	1	0	4	4			
Pre-requisi	Systems ites	Course Assessmen (EA)) CT+EA	nt methods (Continuou	s (CT) and ei	nd assessn	ient			
Course Outcomes• CO1: To explain propagation of light in op • CO2: To recall the working principles of a sources, optical detectors, optical coupli amplifiers, etc.• CO3: To calculate the loss and dispersion various refractive index profiles.TopicsTopic 1: Importance of Optical Fiber communication					lectronic de optical mo	vices like dulators,	optical			
Topics Covered	Modes, Step-In	tance of Optical Fil dex Fiber Structure Slab Waveguide.					-			
	Equation, Mode Step-index Fibe	well's Equations, es in Step-Index F ers. Single-mode f Fibers. Graded-Ind	ibers, Line ibers; Mod	early Polar le-Field D	ized Modes	s, Power	Flow in			
	Cladding Losse Waveguide Dis	Topic 3: Attenuation; Absorption, Scattering Losses, Bending Losses, Core and Cladding Losses. Signal distortion in Optical Waveguides; Material Dispersion, Waveguide Dispersion, Signal Distortion in Single-mode Fibers, Polarization-Mode dispersion, Intermodal Distortion. Pulse Broadening in Graded-Index waveguides.								
	and LED Powe equations, Qua patterns, single	Emitting Diodes (er, Modulation of a antum efficiency, -mode lasers, mod i-n, APD, phototran	in LED. La resonant ulation, ef	aser Diode frequencie fects of te	es; threshold es, structur mperature.	l conditic e and r Optical c	adiation letector,			
Text Book and/or reference material	1. Optical F Editions 2. Fiber Opt Reference Bool 1. Fiber-O Pearson	ics and Optoelectro	onics-R. P.	Khare - O ology- D	xford Unive K. Mynbae	ersity Pres	Hill Int. 55 Cheiner-			

		Department o					
	Title of the course	Program Core	Total Number of contact hours				Credit
Code		(PCR) / Electives (PEL)	Lecture	Tutoria	Practical	Total	
PH9023	Electron Optics	PEL	(L) 3	l (T)	(P) 0	Hours 4	4
	& Microscopy	FLL	5	1	0	4	4
Pre-requisites		Course Assessment methods (Continuous (CT) and end assessment (EA))					
NIL		CT+EA					
Course Outcomes	the adva • CO2: To and TEM	o differentiate betw ntages of electron i o show an understa A microscopies. To outline variou opy.	microscopy anding of t	y he operati	ng principle	s of AFN	л, STM
Topics Covered	hniques l Ind related I). Absorptio	nalysis (ED backscatterin scanning p on, transmis uminescenc	PS), trans	[14] rometry [7] roscopy [15] ection,			
Text Books and/or 1 reference material 2	 Press (2008). 2. D. K. Schroder, Semiconductor Material and Device Characterization, 3rd Edition, Wiley-IEEE Press (2006). Reference Books: 1. P. E. J. Flewitt and R K Wild, Physical methods for Materials Characterization, IOP Publishing (2003). 						l ation,